













CSD16415Q5

SLPS259A - DECEMBER 2011 - REVISED SEPTEMBER 2015

# **CSD16415Q5 25-V N-Channel NexFET™ Power MOSFET**

### **Features**

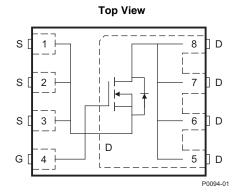
- Ultralow Q<sub>a</sub> and Q<sub>ad</sub>
- Very Low On-Resistance
- Low Thermal Resistance
- Avalanche Rated
- Pb-Free Terminal Plating
- **RoHS Compliant**
- Halogen-Free

## 2 Applications

- Point-of-Load Synchronous Buck Converter for Applications in Networking, Telecom, and Computing Systems
- Optimized for Synchronous FET Applications

### 3 Description

This 25 V, 1.3 m $\Omega$ , 5 x 6 mm SON NexFET<sup>TM</sup> power MOSFET has been designed to minimize losses in power conversion applications.



#### R<sub>DS(ON)</sub> vs V<sub>GS</sub> 5 $T_C = 25^{\circ}C$ , $I_D = 40$ A 4.5 $T_C = 125^{\circ}C$ , $I_D = 40 A$ R<sub>DS(on)</sub> - On-State Resistance (mΩ) 4 3.5 3 2.5 2 1.5 0.5 0 3 4 5 10 V<sub>GS</sub> - Gate-to-Source Voltage (V)

### **Product Summary**

$T_A = 25$	°C	VALU	IE	UNIT
$V_{DS}$	Drain-to-Source Voltage	25		V
$Q_g$	Gate Charge, Total (4.5 V)	21		nC
$Q_{gd}$	Gate Charge, Gate-to-Drain	5.2	nC	
В	Drain-to-Source On	V <sub>GS</sub> = 4.5 V	1.5	mΩ
R <sub>DS(on)</sub>	Resistance	V <sub>GS</sub> = 10 V 0.99		mΩ
V <sub>GS(th)</sub>	Threshold Voltage	1.5		V

## **Device Information**<sup>(1)</sup>

DEVICE	PACKAGE	MEDIA	QTY	SHIP
CSD16415Q5	SON 5-mm × 6-mm Plastic Package	13-inch Reel	2500	Tape and Reel

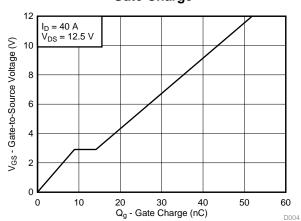
(1) For all available packages, see the orderable addendum at the end of the data sheet.

### **Absolute Maximum Ratings**

Absolute Maximum Natings										
$T_A = 25$	°C	VALUE	UNIT							
$V_{DS}$	Drain-to-Source Voltage	25	٧							
V <sub>GS</sub>	Gate-to-Source Voltage	-12 to 16	V							
I <sub>D</sub>	Continuous Drain Current (Package Limited)	100								
	Continuous Drain Current (Silicon Limited), T <sub>C</sub> = 25°C <sup>(1)</sup>	261	Α							
	Continuous Drain Current <sup>(1)</sup>	38								
I <sub>DM</sub>	Pulsed Drain Current, T <sub>A</sub> = 25°C <sup>(2)</sup>	200	Α							
п	Power dissipation <sup>(1)</sup>	3.2	W							
$P_D$	Power Dissipation, , T <sub>C</sub> = 25°C	156	VV							
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature	-55 to 150	°C							
E <sub>AS</sub>	Avalanche Energy, Single-Pulse $I_D = 100 \text{ A}, L = 0.1 \text{ mH}, R_G = 25 \Omega$	500	mJ							

- $R_{\theta JA}$  = 40°C/W on 1 in² (6.45 cm²) Cu [2 oz. (0.071 mm thick)] on 0.060 inch (1.52 mm) thick FR4 PCB. Max  $R_{\theta JC}$  = 0.8°C/W, pulse duration ≤100  $\mu s$ , duty cycle ≤1%

#### **Gate Charge**





# **Table of Contents**

2 3 4	Features 1   Applications 1   Description 1   Revision History 2   Specifications 3   5.1 Electrical Characteristics 3   5.2 Thermal Information 3   5.3 Thermal MOSEET Characteristics 4	6.2 Trademarks	
6	5.2 Thermal Information	7.2 Recommended PCB Pattern	

# **4 Revision History**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

CI	hanges from Original (August 2014) to Revision A	Page
•	Added part number to title	1
•	Enhanced Description	1
•	Added Device and Documentation Support section and Mechanical, Packaging, and Orderable Information section.	1
•	Updated pulsed current	1
•	Updated Figure 1 to a normalized R <sub>BJC</sub> curve	4
•	Updated the SOA in Figure 10	5
•	Deleted Package Marking Information section at the end of the data sheet	10



# 5 Specifications

### 5.1 Electrical Characteristics

 $T_A = 25^{\circ}C$  (unless otherwise noted)

1 <sub>A</sub> = 25	C (unless otherwise noted)					
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC	CHARACTERISTICS					
$BV_{DSS}$	Drain-to-Source Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	25			V
$I_{DSS}$	Drain-to-Source Leakage Current	$V_{GS} = 0 \text{ V}, V_{DS} = 20 \text{ V}$			1	μΑ
$I_{GSS}$	Gate-to-Source Leakage Current	$V_{DS} = 0 \text{ V}, V_{GS} = -12 \text{ V} \text{ to } 16 \text{ V}$			100	nA
$V_{GS(th)}$	Gate-to-Source Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	1.2	1.5	1.9	V
ь	Drain-to-Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 40 \text{ A}$		1.5	1.8	$m\Omega$
R <sub>DS(on)</sub>	Diam-to-Source Off Resistance	$V_{GS} = 10 \text{ V}, I_D = 40 \text{ A}$		0.99	1.15	$m\Omega$
9 <sub>fs</sub>	Transconductance	$V_{DS} = 15 \text{ V}, I_D = 40 \text{ A}$		168		S
DYNAMI	IC CHARACTERISTICS					
C <sub>ISS</sub>	Input Capacitance			3150	4100	рF
C <sub>OSS</sub>	Output Capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 12.5 \text{ V}, f = 1 \text{ MHz}$		2530	3300	рF
C <sub>RSS</sub>	Reverse Transfer Capacitance			175	230	рF
$R_g$	Series Gate Resistance			1.2	2.4	Ω
$Q_g$	Gate Charge Total (4.5 V)			21	29	nC
$Q_{gd}$	Gate Charge, Gate-to-Drain	V 40.5 V ID 40.4		5.2		nC
Q <sub>gs</sub>	Gate Charge, Gate-to-Source	V <sub>DS</sub> = 12.5 V, ID = 40 A		8.3		nC
Qg(th)	Gate Charge at Vth			4.8		nC
Q <sub>OSS</sub>	Output Charge	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V		55		nC
t <sub>d(on)</sub>	Turnon Delay Time			16.6		ns
t <sub>r</sub>	Rise Time	V <sub>DS</sub> = 12.5 V, V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 40 A		30		ns
t <sub>d(off)</sub>	Turn Off Delay Time	$R_G = 2 \Omega$		20		ns
t <sub>f</sub>	Fall Time			12.7		ns
DIODE C	CHARACTERISTICS					
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> = 40 A, V <sub>GS</sub> = 0 V		0.85	1	V
Q <sub>rr</sub>	Reverse Recovery Charge	$V_{DD} = 15 \text{ V}, I_F = 40 \text{ A}, \text{ di/dt} = 300 \text{ A/}\mu\text{s}$		72		nC
t <sub>rr</sub>	Reverse Tecovery Time	$V_{DD} = 15 \text{ V}, I_F = 40 \text{ A}, \text{ di/dt} = 300 \text{ A/}\mu\text{s}$		45		ns

### 5.2 Thermal Information

 $T_A = 25$ °C (unless otherwise noted)

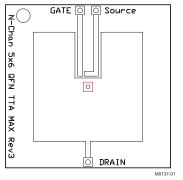
	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Thermal resistance, junction-to-case (1)			0.8	°C/W
$R_{\theta JA}$	Thermal resistance, junction-to-ambient (1) (2)			50	°C/W

<sup>(1)</sup> R<sub>BJC</sub> is determined with the device mounted on a 1 inch (2.54 cm) square, 2 oz. (0.071 mm thick) Cu pad on a 1.5 inch x 1.5 inch (3.81 cm x 3.81 cm), 0.060 inch (1.52 mm) thick FR4 board. R<sub>BJC</sub> is specified by design, whereas R<sub>BJA</sub> is determined by the user's board design.

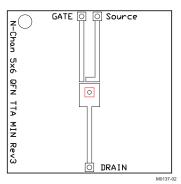
(2) Device mounted on FR4 material with 1 inch<sup>2</sup> (6.45 cm<sup>2</sup>) of 2 oz. (0.071 mm thick) Cu.

Copyright © 2011–2015, Texas Instruments Incorporated





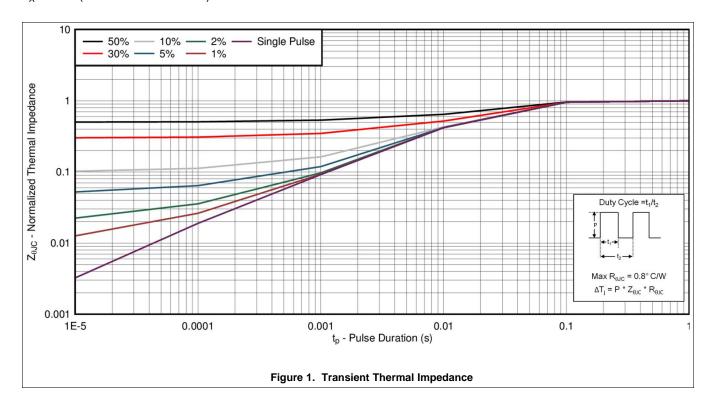
Max  $R_{\theta JA} = 50^{\circ}\text{C/W}$  when mounted on 1 inch<sup>2</sup> (6.45 cm<sup>2</sup>) of 2 oz. (0.071 mm thick) Cu.



Max  $R_{\theta JA} = 125^{\circ}\text{C/W}$  when mounted on minimum pad area of 2 oz. (0.071 mm thick) Cu.

## 5.3 Typical MOSFET Characteristics

 $T_A = 25$ °C (unless otherwise noted)



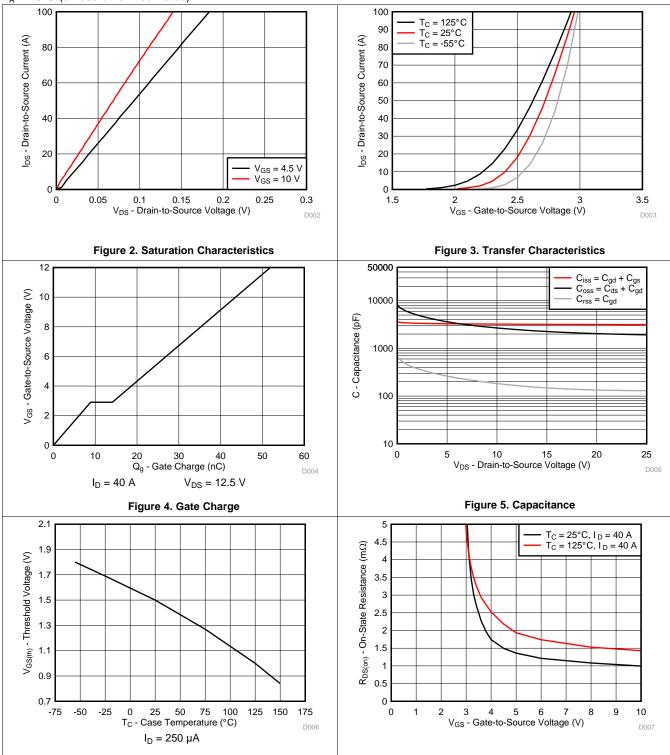
Submit Documentation Feedback

Copyright © 2011–2015, Texas Instruments Incorporated



### **Typical MOSFET Characteristics (continued)**

 $T_A = 25$ °C (unless otherwise noted)



Copyright © 2011–2015, Texas Instruments Incorporated

Figure 6. Threshold Voltage vs Temperature

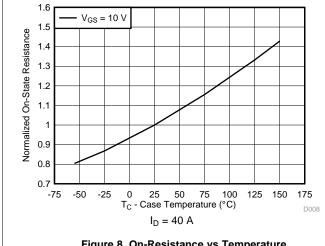
Submit Documentation Feedback

Figure 7. On-Resistance vs Gate Voltage



## **Typical MOSFET Characteristics (continued)**

 $T_A = 25$ °C (unless otherwise noted)



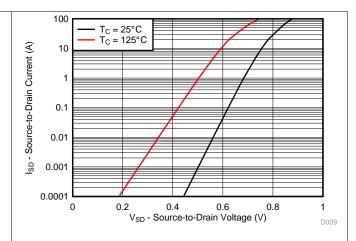
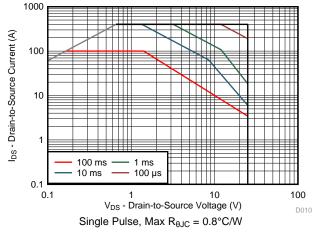


Figure 8. On-Resistance vs Temperature

Figure 9. Typical Diode Forward Voltage



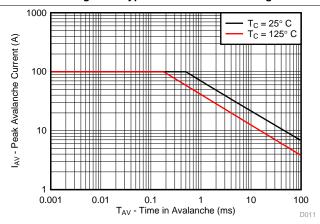


Figure 10. Maximum Safe Operating Area

Figure 11. Single-Pulse Unclamped Inductive Switching

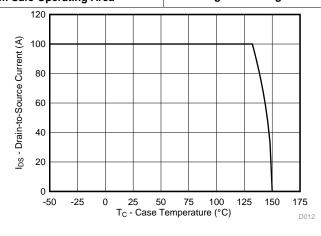


Figure 12. Maximum Drain Current vs Temperature



## 6 Device and Documentation Support

### 6.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Lise

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 6.2 Trademarks

NexFET, E2E are trademarks of Texas Instruments. All other trademarks are the property of their respective owners.

### 6.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### 6.4 Glossary

SLYZ022 — TI Glossary.

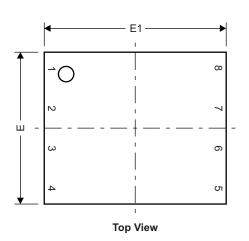
This glossary lists and explains terms, acronyms, and definitions.

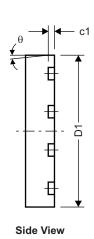


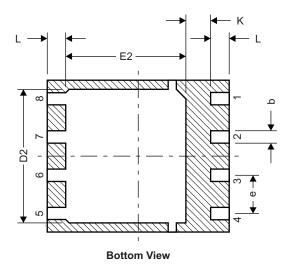
# 7 Mechanical, Packaging, and Orderable Information

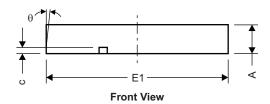
The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## 7.1 Q5 Package Dimensions







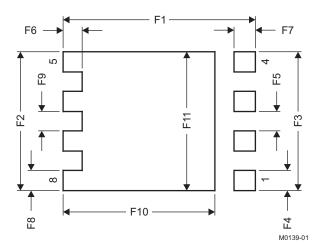


M0140-01

DIM	MI	LLIMETERS			INCHES	
DIIVI	MIN	TYP	MAX	MIN	TYP	MAX
Α	0.950		1.050	0.037		0.039
b	0.360		0.460	0.014		0.018
С	0.150		0.250	0.006		0.010
c1	0.150		0.250	0.006		0.010
D1	4.900		5.100	0.193		0.201
D2	4.320		4.520	0.170		0.178
Е	4.900		5.100	0.193		0.201
E1	5.900		6.100	0.232		0.240
E2	3.920		4.12	0.154		0.162
е		1.27			0.050	
K	0.760			0.030		
L	0.510		0.710	0.020		0.028
θ	0.00					



## 7.2 Recommended PCB Pattern



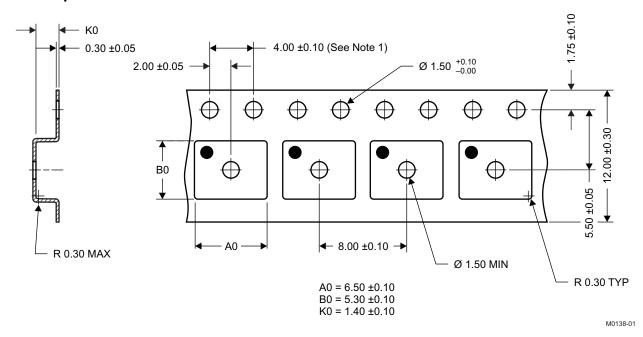
DIM	MILLIMETERS	INCHES	
DIM	MIN MA	X MIN	MAX
F1	6.205 6.30	5 0.244	0.248
F2	4.460 4.56	0.176	0.180
F3	4.460 4.56	0.176	0.180
F4	0.650 0.70	0.026	0.028
F5	0.620 0.67	0.024	0.026
F6	0.630 0.68	0.025	0.027
F7	0.700 0.80	0.028	0.031
F8	0.650 0.70	0.026	0.028
F9	0.620 0.67	0.024	0.026
F10	4.900 5.00	0.193	0.197
F11	4.460 4.56	0 0.176	0.180

For recommended circuit layout for PCB designs, see *Reducing Ringing Through PCB Layout Techniques* (SLPA005).

Copyright © 2011–2015, Texas Instruments Incorporated



### 7.3 Q5 Tape and Reel Information



#### Notes:

- 1. 10 sprocket hole pitch cumulative tolerance ±0.2
- 2. Camber not to exceed 1 mm in 100 mm, noncumulative over 250 mm
- 3. Material: black, static-dissipative polystyrene
- 4. All dimensions are in mm (unless otherwise specified)
- 5. A0 and B0 measured on a plane 0.3 mm above the bottom of the pocket
- 6. MSL1 260°C (IR and Convection) PbF Reflow Compatible



## PACKAGE OPTION ADDENDUM

20-Aug-2015

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
CSD16415Q5	ACTIVE	VSON-CLIP	DQH	8	2500	Pb-Free (RoHS Exempt)	CU SN	Level-1-260C-UNLIM	-55 to 150	CSD16415	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.



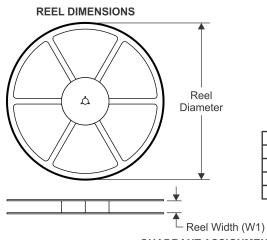


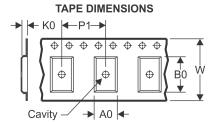
20-Aug-2015

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 20-Aug-2015

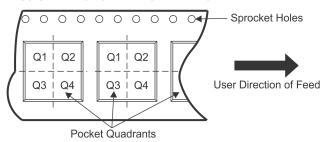
## TAPE AND REEL INFORMATION





		Dimension designed to accommodate the component width
E	30	Dimension designed to accommodate the component length
K	(0	Dimension designed to accommodate the component thickness
	N	Overall width of the carrier tape
F	21	Pitch between successive cavity centers

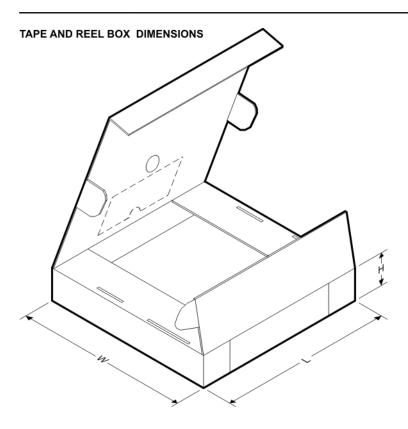
### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



### \*All dimensions are nominal

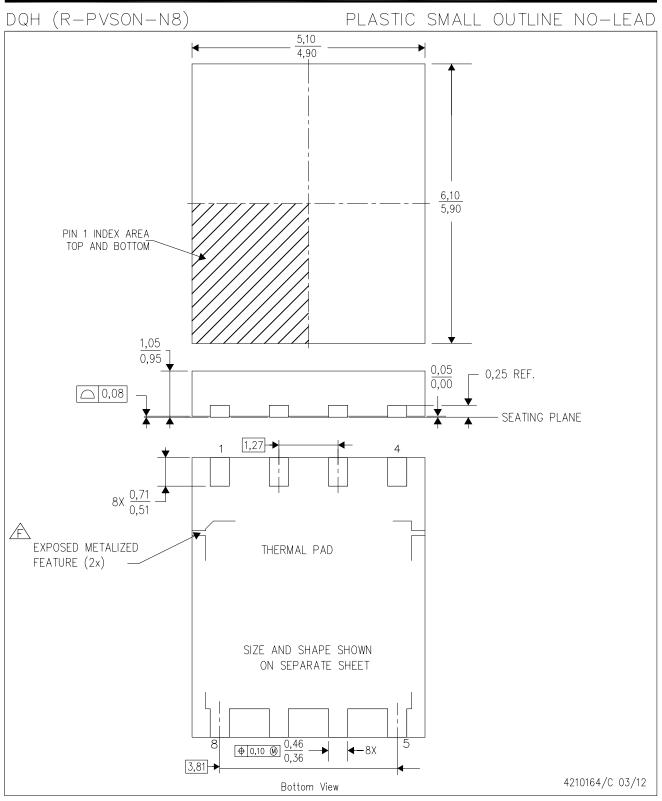
Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD16415Q5	VSON- CLIP	DQH	8	2500	330.0	12.4	6.3	5.3	1.2	8.0	12.0	Q1

www.ti.com 20-Aug-2015



#### \*All dimensions are nominal

I	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
I	CSD16415Q5	VSON-CLIP	DQH	8	2500	336.6	336.6	41.3



- NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
  - B. This drawing is subject to change without notice.
  - C. Small Outline No-Lead (SON) package configuration.
  - D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
  - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
  - A Metalized features are supplier options and may not be on the package.



#### IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

#### Products Applications

Audio www.ti.com/audio Automotive and Transportation www.ti.com/automotive **Amplifiers** amplifier.ti.com Communications and Telecom www.ti.com/communications **Data Converters** dataconverter.ti.com Computers and Peripherals www.ti.com/computers **DLP® Products** www.dlp.com Consumer Electronics www.ti.com/consumer-apps DSP dsp.ti.com **Energy and Lighting** www.ti.com/energy Clocks and Timers www.ti.com/clocks Industrial www.ti.com/industrial Interface interface.ti.com Medical www.ti.com/medical Logic Security www.ti.com/security logic.ti.com

Power Mgmt power.ti.com Space, Avionics and Defense www.ti.com/space-avionics-defense

Microcontrollers microcontroller.ti.com Video and Imaging www.ti.com/video

RFID www.ti-rfid.com

OMAP Applications Processors www.ti.com/omap TI E2E Community e2e.ti.com

Wireless Connectivity www.ti.com/wirelessconnectivity